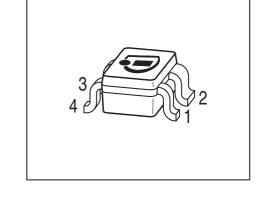


### Low Noise Silicon Bipolar RF Transistor

- Low noise amplifier designed for low voltage applications, ideal for 1.2 V or 1.8 V supply voltage. Supports V<sub>cc</sub> = 2.9 V with enough external collector resistance.
- High gain and low noise at high frequencies due to high transit frequency f<sub>T</sub> = 45 GHz
- Common e.g. in cordless phones and satellite receivers
- Easy to use Pb-free (RoHS compliant) and halogen free industry standard package with visible leads
- Qualification report according to AEC-Q101 available







## **ESD** (Electrostatic discharge) sensitive device, observe handling precaution!

Туре	Marking	Pin Configuration						Package
BFP520	APs	1=B	2=E	3=C	4=E	-	-	SOT343

### **Maximum Ratings** at $T_A$ = 25 °C, unless otherwise specified

Parameter	Symbol	Value	Unit
Collector-emitter voltage	$V_{\sf CEO}$		V
<i>T</i> <sub>A</sub> = 25 °C		2.5	
_T <sub>A</sub> = -55 °C		2.4	
Collector-emitter voltage	$V_{CES}$	10	
Collector-base voltage	$V_{\mathrm{CBO}}$	10	
Emitter-base voltage	$V_{EBO}$	1	
Collector current	$I_{\mathbb{C}}$	50	mA
Base current	$I_{B}$	5	
Total power dissipation <sup>1)</sup>	P <sub>tot</sub>	125	mW
<i>T</i> <sub>S</sub> ≤ 105 °C			
Junction temperature	$T_{J}$	150	°C
Storage temperature	T <sub>Stg</sub>	-55 150	

1

 $<sup>{}^{1}</sup>T_{
m S}$  is measured on the emitter lead at the soldering point to pcb



### **Thermal Resistance**

Parameter	Symbol	Value	Unit
Junction - soldering point <sup>1)</sup>	R <sub>thJS</sub>	450	K/W

# **Electrical Characteristics** at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics			•	•	
Collector-emitter breakdown voltage	V <sub>(BR)CEO</sub>	2.5	3	3.5	V
$I_{\rm C} = 1 \text{ mA}, I_{\rm B} = 0$					
Collector-emitter cutoff current	I <sub>CES</sub>				nA
$V_{CE} = 2 \text{ V}, V_{BE} = 0$		-	1	30	
$V_{CE} = 10 \text{ V}, V_{BE} = 0$				1000	
Collector-base cutoff current	I <sub>CBO</sub>	-	-	30	
$V_{CB} = 2 \text{ V}, I_{E} = 0$					
Emitter-base cutoff current	/ <sub>EBO</sub>	-	100	3000	
$V_{\rm EB} = 0.5  \rm V,  I_{\rm C} = 0$					
DC current gain	h <sub>FE</sub>	70	110	170	-
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 2 V, pulse measured					

 $<sup>^{1}</sup>$ For the definition of  $R_{\mathrm{thJS}}$  please refer to Application Note AN077 (Thermal Resistance Calculation)



**Electrical Characteristics** at  $T_A = 25$ °C, unless otherwise specified

Parameter Parameter $I_A = 25^{\circ}C$ , unless	Symbol		Unit		
		min.	typ.	max.	
AC Characteristics (verified by random sampling	g)				
Transition frequency	f <sub>T</sub>	32	45	-	GHz
$I_{\rm C}$ = 30 mA, $V_{\rm CE}$ = 2 V, $f$ = 2 GHz					
Collector-base capacitance	C <sub>cb</sub>	-	0.07	0.13	pF
$V_{CB} = 2 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0$ ,					
emitter grounded					
Collector emitter capacitance	C <sub>ce</sub>	-	0.3	-	
$V_{CE} = 2 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0$ ,					
base grounded					
Emitter-base capacitance	C <sub>eb</sub>	-	0.33	-	
$V_{\text{EB}} = 0.5 \text{ V}, f = 1 \text{ MHz}, V_{\text{CB}} = 0$ ,					
collector grounded					
Minimum noise figure	NF <sub>min</sub>	-	0.95	-	dB
$I_{\rm C}$ = 2 mA, $V_{\rm CE}$ = 2 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$ ,					
f = 1.8 GHz					
Power gain, maximum stable <sup>1)</sup>	G <sub>ms</sub>	-	24	-	dB
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 2 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$ , $Z_{\rm L}$ = $Z_{\rm Lopt}$ ,					
f = 1.8 GHz					
Insertion power gain	$ S_{21} ^2$	-	21.5	-	
$V_{CE} = 2 \text{ V}, I_{C} = 20 \text{ mA}, f = 1.8 \text{ GHz},$					
$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$					
Third order intercept point at output	IP <sub>3</sub>				dBm
$V_{CE}$ = 2 V, $I_{C}$ = 20 mA, $f$ = 1.8 GHz,					
$Z_{S} = Z_{Sopt}, Z_{L} = Z_{Lopt}$		-	25	-	
$V_{CE} = 2 \text{ V}, I_{C} = 7 \text{ mA}, f = 1.8 \text{ GHz},$					
$Z_{S} = Z_{Sopt}, Z_{L} = Z_{Lopt}$		-	17	-	
1dB compression point at output	P <sub>-1dB</sub>				
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 2 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$ ,					
$Z_{L} = Z_{Lopt}, f = 1.8 \text{ GHz}$		-	12	-	
$I_{\rm C}$ = 7 mA, $V_{\rm CE}$ = 2 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$ ,					
$Z_{L} = Z_{Lopt}$ , $f = 1.8 \text{ GHz}$		-	5	-	

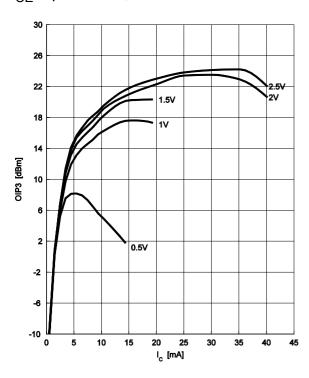
 $<sup>^{1}</sup>G_{\rm ms} = |S_{21} / S_{12}|$ 



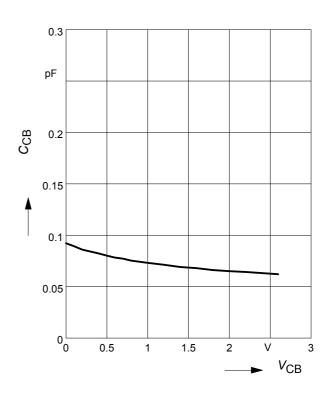
# Total power dissipation $P_{tot} = f(T_S)$

# mW

Third order Intercept Point  $IP_3$  = f ( $I_C$ ) (Output,  $Z_S$  =  $Z_L$  = 50  $\Omega$  )  $V_{CE}$  = parameter, f = 900 MHz



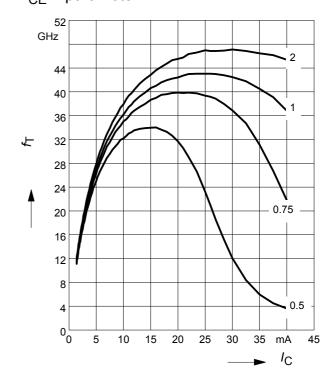
# Collector-base capacitance $C_{cb}$ = $f(V_{CB})$ f = 1MHz



## Transition frequency $f_T = f(I_C)$

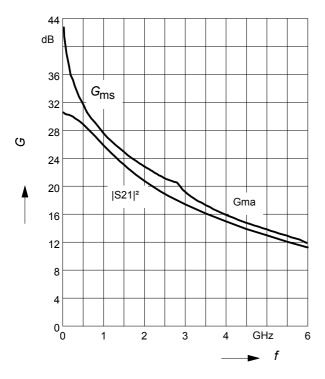
f = 2 GHz

 $V_{CE}$  = parameter in V

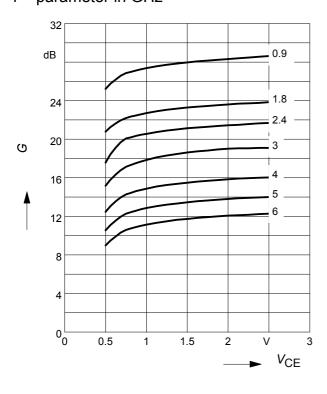




Power gain  $G_{ma}$ ,  $G_{ms}$ ,  $|S_{21}|^2 = f(f)$  $V_{CF} = 2 \text{ V}$ ,  $I_{C} = 20 \text{ mA}$ 



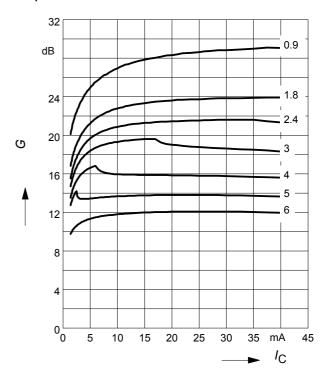
Power gain  $G_{ma}$ ,  $G_{ms} = f(V_{CE})$   $I_{C} = 20 \text{ mA}$ f = parameter in GHz



Power gain  $G_{ma}$ ,  $G_{ms} = f(I_C)$ 

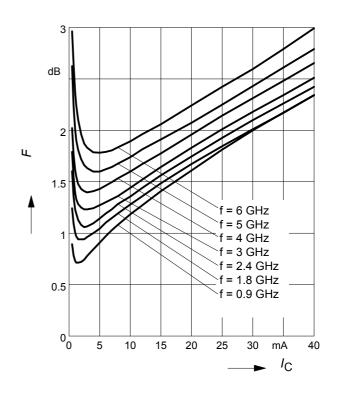
$$V_{CE} = 2V$$

f = parameter in GHz



Minimum noise figure  $NF_{min} = f(I_C)$ 

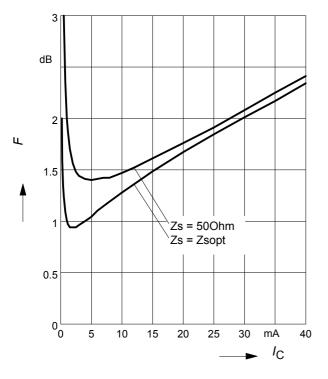
$$V_{CE}$$
 = 2 V,  $Z_{S}$  =  $Z_{Sopt}$ 





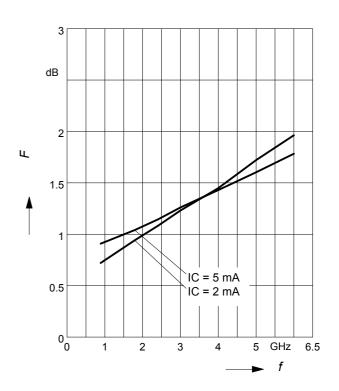
Noise figure  $F = f(I_C)$ 

 $V_{CE} = 2 \text{ V}, f = 1.8 \text{ GHz}$ 



Minimum noise figure  $NF_{min} = f(t)$ 

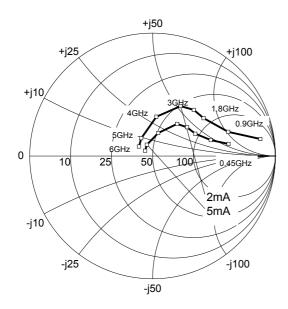
 $V_{CE}$  = 2 V,  $Z_{S}$  =  $Z_{Sopt}$ 



Source impedance for min.

noise figure vs. frequency

 $V_{\rm CE}$  = 2 V,  $I_{\rm C}$  = 2 mA / 5 mA





#### SPICE GP Model

For the SPICE Gummel Poon (GP) model as well as for the S-parameters (including noise parameters) please refer to our internet website www.infineon.com/rf.models.

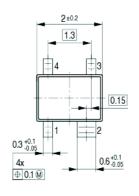
Please consult our website and download the latest versions before actually starting your design. You find the BFP520 SPICE GP model in the internet in MWO- and ADS-format, which you can import into these circuit simulation tools very quickly and conveniently. The model already contains the package parasitics and is ready to use for DC and high frequency simulations. The terminals of the model circuit correspond to the pin configuration of the device. The model parameters have been extracted and verified up to 10 GHz using typical devices. The BFP520 SPICE GP model reflects the typical DC- and RF-performance within the limitations which are given by the SPICE GP model itself. Besides the DC characteristics all S-parameters in magnitude and phase, as well as noise figure (including optimum source impedance, equivalent noise resistance and flicker noise) and intermodulation have been extracted.

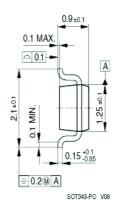
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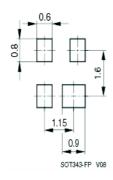
# Package Outline



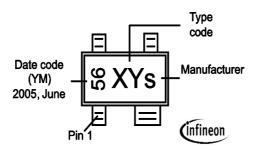




### **Foot Print**

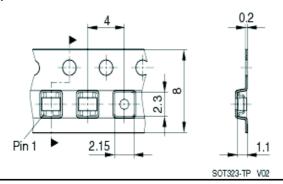


# Marking Layout (Example)



# **Standard Packing**

Reel Ø180 mm = 3.000 Pieces/Reel Reel Ø330 mm = 10.000 Pieces/Reel



Package SOT 343.vsd



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2013-04-23